

Empirical Study on the Performance of Patent Strategy of China

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ABSTRACT

Since the middle age of 1980s, China has made great performance at economic growth, and greatly improved its innovation level. As the representation index of innovation activity, patents number growth is also significant. This paper constructed quintic overdetermined equation of one variable to simulate the trend of patent number varying with the time from 1985 to 2010, made use of Matlab Software and took the solution of simulation model. By comparing the simulation curve and real data curve, good agreement is obtained. After F-test and comparison between the simulation data and real data of 2008, 2009, 2010 respectively, it is believed that the simulation model is reliable. Based on this model, scientific estimation about the variation of Chinese patents from 2011 to 2014 is presented.

Keywords: Patent, Simulation Model, Overdetermined Equation, Matlab

1. Introduction

Since 1980s, world economy structure is undergoing a new round of major adjustment. High technology industry rises quickly, which radiates and drives the development of the whole economy. National trades and investment activities are increasingly active, the competition between countries and enterprises is more intensive. This entire situation makes global economy, science and technology development pattern undergo a profound and significant change. The overall trend of world economy growth has had a profound and important influence on the international protection of intellectual property rights. Economic competition between countries has already been translated into competition of patents. For developed countries, patent strategy is one part of its global strategy to monopolize the global market. More and more countries and enterprises realize that intellectual property is the most important strategic resource for improving their core competition capabilities [1].

As a member of WTO, China has its crucial task to develop high-tech industries in order to meet the challenge of globalization. In Jun 5, 2008, the Sate Council promulgated "Outline of the national intellectual property strategy", decided to put intellectual property strategy into effect. Based on this situation, it is significant to find the rule of change and supply some advices for government decisions by studying on the trend of patents quantities in China from the middle age of 1980s till now.

2. Data Source and Model Design

From the website of State Intellectual Property Office (SIPO), we can find the whole sum of patents of China from 1985 to 2010, including invention patent, utility model patent and design patent, as shown in **Table 1**. In this paper, according to the patents number of each year, a simulation model of overdetermined equation group is constructed to describe the variation and developmental trends of patents from 1985 to 2007. To verify the fitting degree of the simulation model, patents data of 2008, 2009 and 2010 forecasted by the simulation model was compared with the real data published at the website of SIPO. Additionally, statistics test methods such as *F* test are used to verify the fitting degree. The whole solving process is underdone by Matlab software.

According to the data shown in **Table 1**, a trend curve of the number of patents (observed value) varying with the time (year) is drawn. Assume that there has one parallel curve intersect with the trend curve, k points are obtained. Regarding time (year) X_i as independent variable, number of patents Y_i as dependent variable, k overdetermined equation of one variable is constructed [2,3], as shown in Equation (1).

Year	Whole Sum of Patents	Inventi	Invention Patens		Utility Model Patents		Design Patents	
	Number	Number	Percent (%)	Number	Percent (%)	Number	Percent (%)	
2007	351782	67948	19.32	150036	42.65	133798	38.03	
2006	268002	57786	21.56	107655	40.17	102561	38.27	
2005	214003	53305	24.91	79349	37.08	81349	38.01	
2004	190238	49360	25.95	70623	37.12	70255	36.93	
2003	182226	37154	20.39	68906	37.81	76166	41.80	
2002	132401	21476	16.22	57483	43.42	53442	40.36	
2001	114252	16297	14.26	54359	47.58	43596	38.16	
2000	105345	12683	12.04	54743	51.97	37919	36.00	
1999	100156	7637	7.63	56368	56.28	36151	36.09	
1998	67889	4733	6.97	33902	49.94	29254	43.09	
1997	50996	3494	6.85	27342	53.62	20160	39.53	
1996	43781	2977	6.80	27171	62.06	13633	31.14	
1995	45064	3393	7.53	30471	67.62	11200	24.85	
1994	43297	3883	8.97	32819	75.80	6595	15.23	
1993	62127	6556	10.55	46639	75.07	8932	14.38	
1992	31475	3966	12.60	24060	76.44	3449	10.96	
1991	24616	4122	16.75	17327	70.39	3167	12.87	
1990	22588	3838	16.99	16952	75.05	1798	7.96	
1989	17129	2303	13.45	13508	78.86	1318	7.69	
1988	11947	1025	8.58	10191	85.30	731	6.12	
1987	6811	422	6.20	5768	84.69	621	9.12	
1986	3024	56	1.85	2530	83.66	438	14.48	
1985	138	40	28.99	60	43.48	38	27.54	

Table 1. Data of patens of China from 1985 to 2007.

a. Data Source: website of SIPO of China http://www.sipo.gov.cn/tjxx/.

$$y_t = a_1 x_t^k + a_2 x_t^{k-1} + \dots + a_{k-1} x_t^2 + a_k x_t + a_{k+1}$$
(1)

In which, $k \ge 1$, a_1, a_2, \dots, a_{k+1} are constants.

In matrix forms, Equation (1) can be written as follows,

$$\mathbf{Y}_{t\times 1} = \mathbf{X}_{t\times (k+1)} \mathbf{A}_{(k+1)\times 1}$$
(2)

In which,

$$\mathbf{Y}_{t\times 1} = \begin{bmatrix} y_1, y_2, \dots, y_t \end{bmatrix}^{\mathrm{T}}, \quad \mathbf{A}_{(k+1)\times 1} = \begin{bmatrix} a_1, a_2, \dots, a_{k+1} \end{bmatrix}^{\mathrm{T}},$$
$$\mathbf{X}_{t\times (k+1)} = \begin{bmatrix} x_1^k & x_1^{k-1} & \cdots & x_1^1 & 1 \\ x_2^k & x_2^{k-1} & \cdots & x_2^1 & 1 \\ \vdots & \ddots & \vdots & \vdots \\ x_t^k & x_t^{k-1} & \cdots & x_t^1 & 1 \end{bmatrix}$$
(3)

3. Account Case

Take the year number shown in **Table 1** into $\mathbf{Y}_{t\times 1}$ of equation (2), the data of patents into equation (3), *K* overdetermined equation of one variable about parameter

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 $\mathbf{A}_{(k+1)\times 1}$ is gotten. Under this condition, parameter $\mathbf{A}_{(k+1)\times 1}$ of Equation (2) has a least square solution $\mathbf{A}_{(k+1)\times 1}$, thus the equation $\|\mathbf{X}_{t\times (k+1)} \circ \mathbf{A}_{(k+1)\times 1} - \mathbf{Y}_{t\times 1}\|_{2}$ has a minimum sotion [4] which could be expressed as:

$$\left\|\mathbf{X}_{t\times(k+1)}\hat{\mathbf{A}}_{(k+1)\times 1} - \mathbf{Y}_{t\times 1}\right\|_{2} = \min\left\|\mathbf{X}_{t\times(k+1)}\mathbf{A}_{(k+1)\times 1} - \mathbf{Y}_{t\times 1}\right\|_{2}$$
(4)

3.1. About the Total Amount of Patents

Make use of Equation (1), and appoint k = 5, a quintic polynomial is utilized to process fitting. The total amount of patents is Y_0 , time number is x_t , and then the total amount of patents varying with the time can be expressed as:

$$Y_0 = a_1 x_t^5 + a_2 x_t^4 + a_3 x_t^3 + a_4 x_t^2 + a_5 x_t + a_6$$
(5)

Take the data "whole Sum of Patents" shown in **Table 1** into (5), and dissolve the overdetermined equation group

constructed by (5), solutions of parameters are: $a_1 = 0.27$, $a_2 = -12.42$, $a_3 = 239.85$, $a_4 = -2068.49$, $a_5 = 2010.36$ and $a_6 = -12982.78$. The comparison figure between simulation curve and real curve is shown in **Figure 1**.

3.2. About the Invention Patents

The same as section 3.1, appoint the number of invention patents is Y_1 and time (year) is x_t , number of patents varying with time can be expressed as:

$$Y_1 = a_1 x_t^5 + a_2 x_t^4 + a_3 x_t^3 + a_4 x_t^2 + a_5 x_t + a_6$$
(6)

Take the data "invention patents" shown in **Table 1** and dissolve the overdetermined equation group constructed by (6), the solution of parameters can be obtained as: $a_1 = -0.322$, $a_2 = 18.33$, $a_3 = -351.53$, $a_4 = 2761.10$, $a_5 = -7793.88$, $a_6 = 6216.43$. The comparison figure between simulation curve and real curve is shown in **Figure 2**.



Figure 1. The comparison between simulation curve and real curve of whole sum of patents.



Figure 2. The comparison between simulation curve and real curve of invention patents.

3.3. About the Utilize Model Patents

The same as section 3.1, appoint the number of invention patents is Y_2 and the time (year) is x_i , the number of patents varying with time can be expressed as:

$$Y_2 = a_1 x_t^5 + a_2 x_t^4 + a_3 x_t^3 + a_4 x_t^2 + a_5 x_t + a_6$$
(7)

Take the data "invention patents" shown in **Table 1** and dissolve the overdetermined equation group constructed by (6), the solutions of parameters are obtained as: $a_1 = -0.31$, $a_2 = -15.20$, $a_3 = 272.86$, $a_4 = -2213.33$, $a_5 = 11154.51$, $a_6 = -11638.51$. The simulation curve and the real curve are shown in **Figure 3**.

3.4. About the Design Patents

The same as section 3.1, appoint the number of invention patents is Y_3 and the time (year) is x_t , the number of patents varying with time can be expressed as:

$$Y_3 = a_1 x_t^5 + a_2 x_t^4 + a_3 x_t^3 + a_4 x_t^2 + a_5 x_t + a_6$$
(8)

Take the data "design patents" shown in **Table 1** and dissolve the overdetermined equation group (8), the solution of parameters are achieved as: $a_1 = 0.28$, $a_2 = -15.82$, $a_3 = 325.24$, $a_4 = -2691.60$, $a_5 = 9023.94$, $a_6 = -8186.80$. The comparison between simulation curve and real curve is shown in **Figure 4**.

3.5. Forecast data

From the above description, it is believed that the fitting degree between the simulated and real curve is good. The simulation model can be used to forecast the data of coming years. The forecast patents data of 2011, 2012, 2013 and 2014 are shown in **Table 2**.

From **Table 2**, it can be seen that the growth rate of patents keeps about 30% in the coming years, and the growth rate of invention patents is slower than those of other two kinds of patents.

4. Test Method and Result

4.1. F-Test

In order to test the reliability of the simulation model, *F*-test method is used as below.

Total sum of squares of deviations:

$$Q_T = \sum_{i=1}^n \left(y_i - \bar{y} \right)^2 \tag{9}$$

Equation (9) described the total dispersion degree of the observe value $y_1, y_2, \dots y_n$ for dependable variable Y. Decompounds Q_T to two parts, that is, square sum of residuals (Q_E) and sum of squares of deviations in regression (Q_R)

$$Q_T = Q_E + Q_R \tag{10}$$

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Figure 3. The comparison between simulation curve and real curve of utilize model patents.



Figure 4. The comparison between simulation curve and real curve of design patents.

Table 2.	I ne forecast	data of the	coming years.	

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Vear	Whole Sum of Patents		Invention Patens		Utility Model Patents		Design Patents	
I cai	Number	Growth Rate	Number	Growth Rate	Number	Growth Rate	Number	Growth Rate
2011	1059688	30.05	165191	22.26	437133	26.89	457454	36.45
2012	1407002	32.27	194591	17.79	585540	33.94	627082	37.08
2013	1853821	31.75	227576	16.95	776802	32.66	849842	35.52
2014	2420316	30.56	264400	16.18	1019460	31.23	1137133	33.81

	Year	Whole Sum of Patents	Invention Patents	Utilize Model Patents	Design Patents
	Real Data	814825	135110	344472	335243
2010	Forecast data	632683	121381	331258	353126
	Error	-22.35%	-10.16%	-3.83%	5.33%
	Real Data	581992	128489	203802	249701
2009	Forecast data	513895	103381	250291	248039
	Error	-11.70%	-19.54%	22.81%	-0.66%
	Real Data	411982	93706	176675	141601
2008	Forecast data	417802	87284	189210	147997
	Error	1.41%	-6.85%	7.09%	4.51%

Table 3. Compare between forecast data and real data of 2008-2010.

In which

$$Q_E = \sum_{i=1}^{n} \left(y_i - \hat{y}_i \right)^2; \quad Q_R = \sum_{i=1}^{n} \left(\hat{y}_i - \bar{y}_i \right)^2$$

test statistics:

$$F = \frac{Q_R / k}{Q_E / (n - k - 1)} \sim F(k, n - k - 1)$$
(11)

As for the given significance α , test whether F is bigger than F_{α} .

• To test Equation (5), n = 23, k = 6

We can get $Q_T = 1.9211e + 011$; $Q_R = 1.8976e + 011$;

 $Q_E = 2.3542e + 009$. $F = 214.9479 > F_{0.01}(6, 16) = 4.20$. • To test Equation (6)

We can get $Q_T = 9.9524e + 009$; $Q_R = 9.8738e + 009$; $Q_E = 7.8567e + 007$. $F = 335.1285 > F_{0.01}(6, 16) = 4.20$. • To test Equation (7)

We can get $Q_T = 2.8411e + 010$; $Q_R = 2.7276e + 010$; $Q_E = 1.1346e + 009$. $F = 64.1051 > F_{0.01}(6, 16) = 4.20$. • To test Equation (8)

We can get $Q_T = 3.1413e + 010$; $Q_R = 3.1093e + 010$; $Q_E = 3.2013e + 008$. $F = 259.0053 > F_{0.01}(6, 16) = 4.20$. From the test result, we can conclude that Equation (5), (6), (7) and (8) all reach the significance level.

4.2. Observe Data Test

We can also use the simulation model to forecast the patents number of 2008, 2009, and 2010, thus further test the significance of the model by comparing the simulation data with the real data published at the website of SIPO. The results are shown in **Table 3**.

From the above table, it can be concluded that the maximum error between the forecast data and real data is about 20%, the minimum error is less than 1%. The errors are tolerable, thus the simulation model is effective.

5. Conclusions

Firstly, the trend of patents number varying with time from 1985 to 2010 in China can be explained by quintic overdetermined equation of one variable. Three kinds of patens, that is, invention patent, utilize model patent and design patent, are all showing the same trend. The fitting degree is well. Under the F-test and observe data test, the significance level of the simulation model is also good. Secondly, from the simulation model, we can get the forecast data about the several coming years. It is helpful for decision support. Thirdly, the distinction between three kinds of patents is that the growth rate is different, invention patent is slowest, and design patent is fastest. This phenomenon should be taken into consideration. And finally, the curve is steep, especially after 2000, it shows that self-innovation strategy of China has taken great effect in the decades.

REFERENCES

- S.-J. Zhang, "Literature Review of Patent Strategy Study in China," *Management of Science and Technology*, Vol. 2, 2011, pp. 174-175.
- [2] Z.-Q. GE and J. Yang, "The Experimental Study on the Patent Application of Universities and Colleges in China," *Journal of UESTC of China*, Vol. 35, No. 2, 2006, pp. 285-286.
- [3] Z.-Q. GE, B. Zhang and T. Jin, "An Empirical Study on the Relationship between Input of R & D and Patent in China," *Proceedings of* 2004 *International Conference on Management Science and Engineering*, Orient Academic Forum Beijing-Sidney, September 15-25, 2004, pp. 118-120.
- [4] B.-J. Li and H.-Y. Liu, "A Solving Method of Overdetermined Systems," *Journal of Shenyang University of Technology*, Vol. 24, No.1, 2002, pp. 76-77.